



# Neural Interfaces

## Exercise 2

Fall 2025

# Basics: Silicon vs silicones

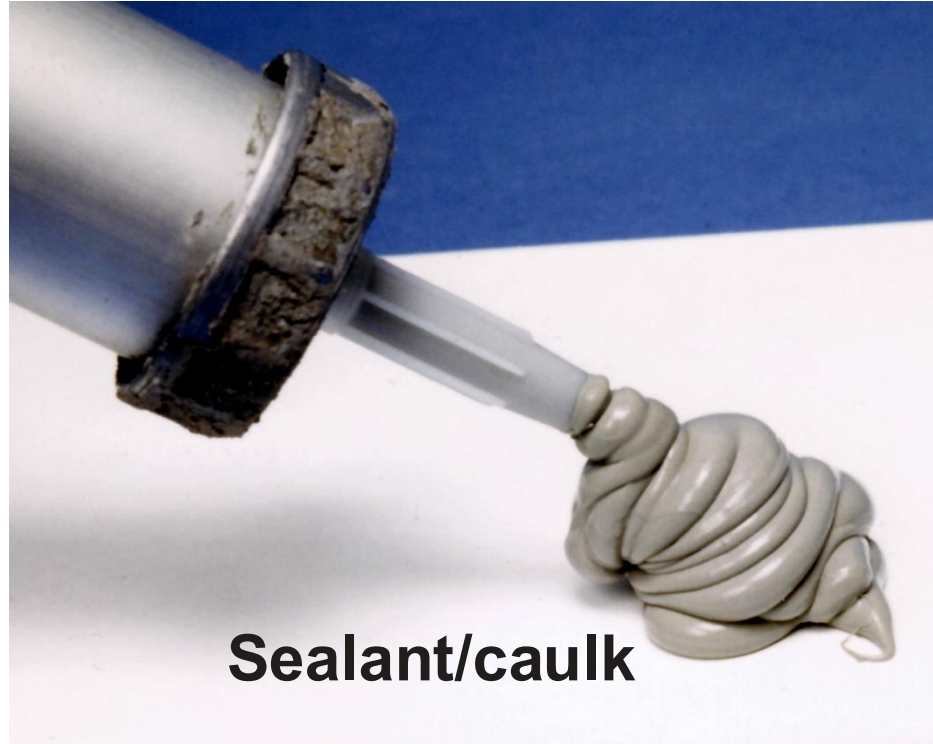
## Silicon (Si)

## Silicones

4"



Silicon wafer



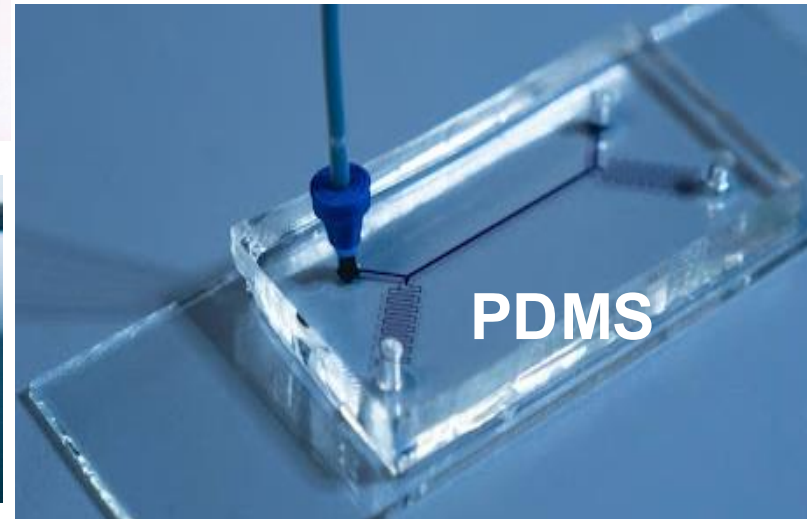
Sealant/caulk



PDMS



PDMS



PDMS

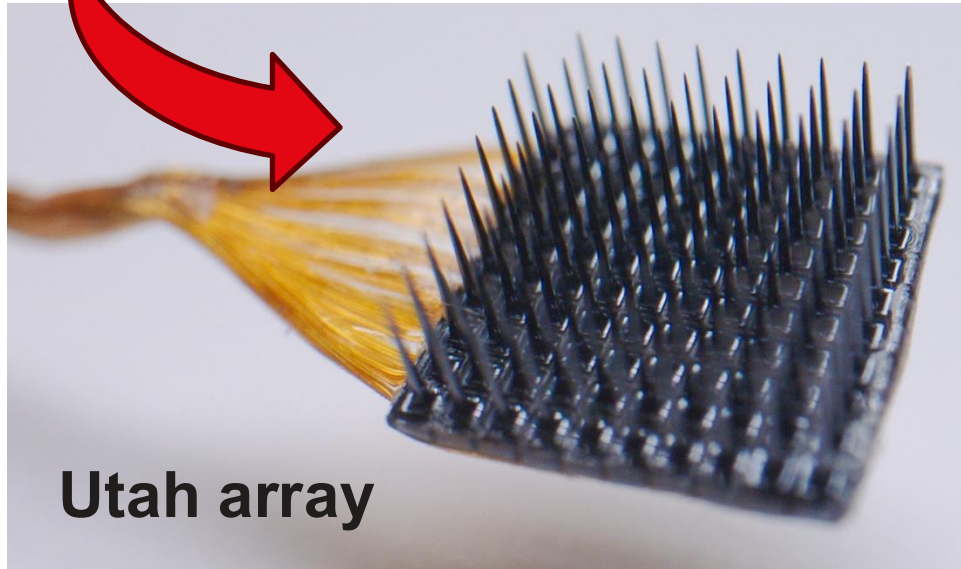
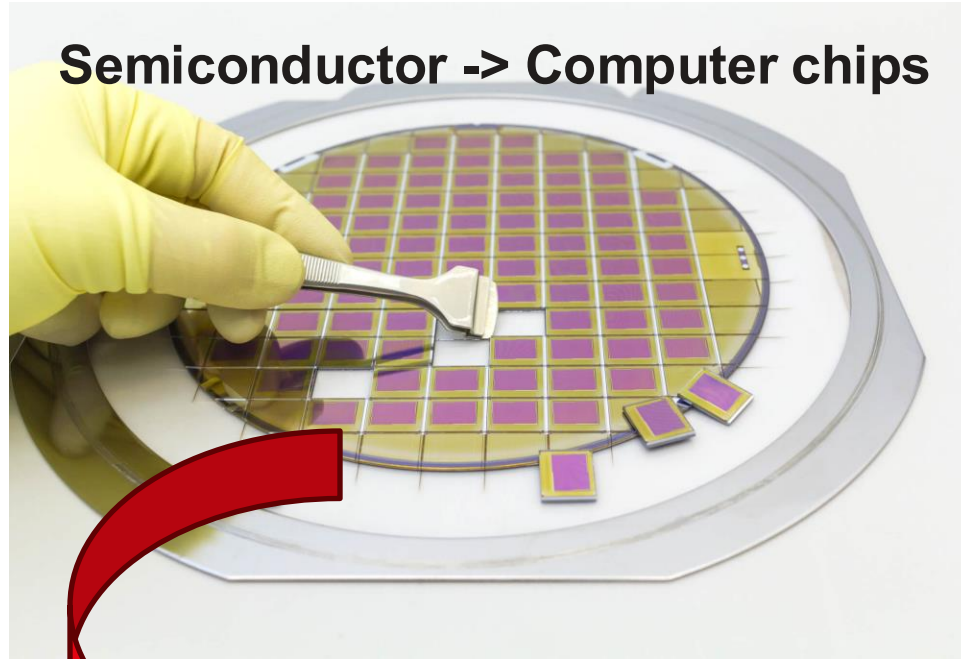
## Silicon (Si)

4"



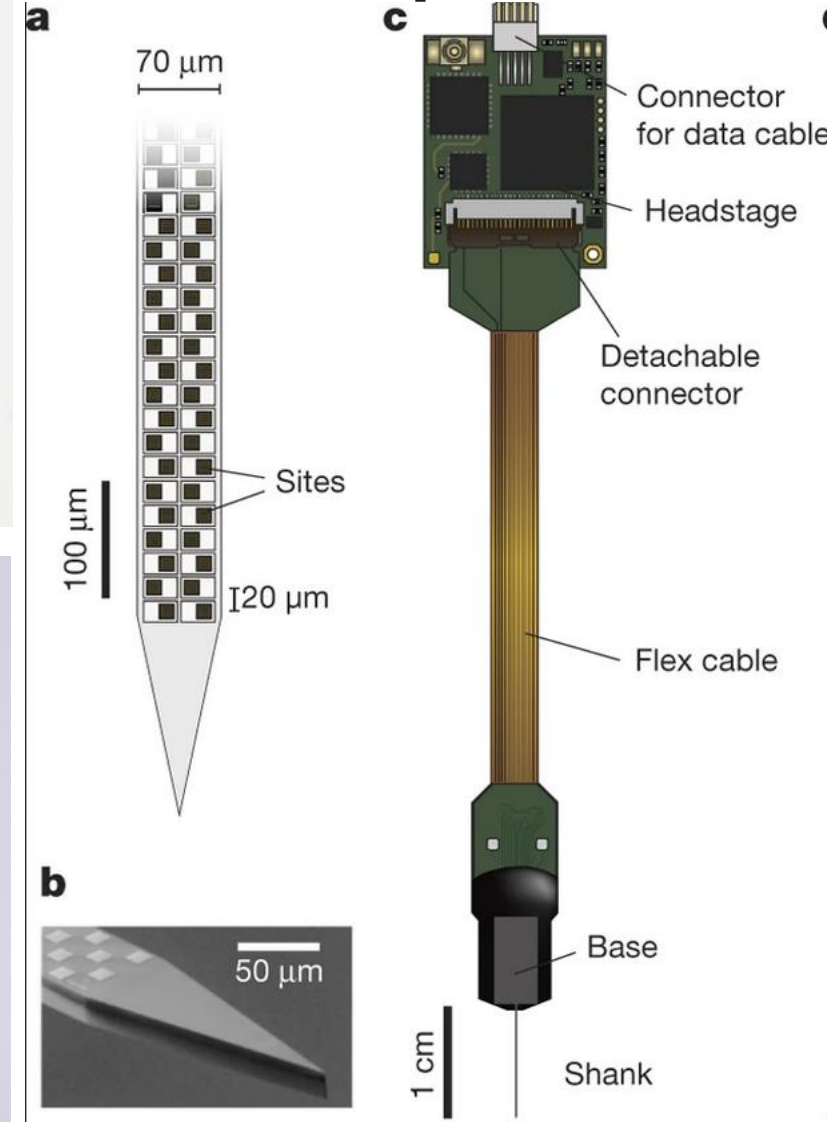
Use standard clean room fabrication processes to create neural interfaces

## Semiconductor -> Computer chips



Utah array

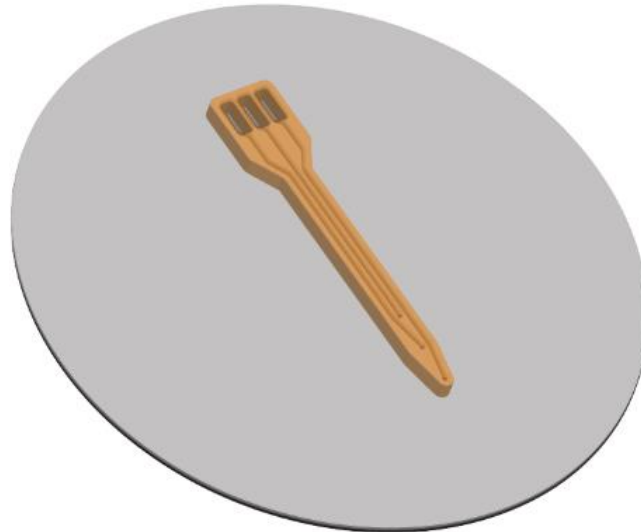
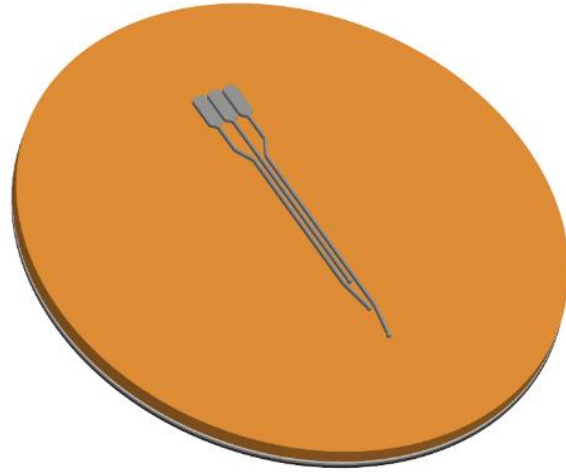
## Neuropixels



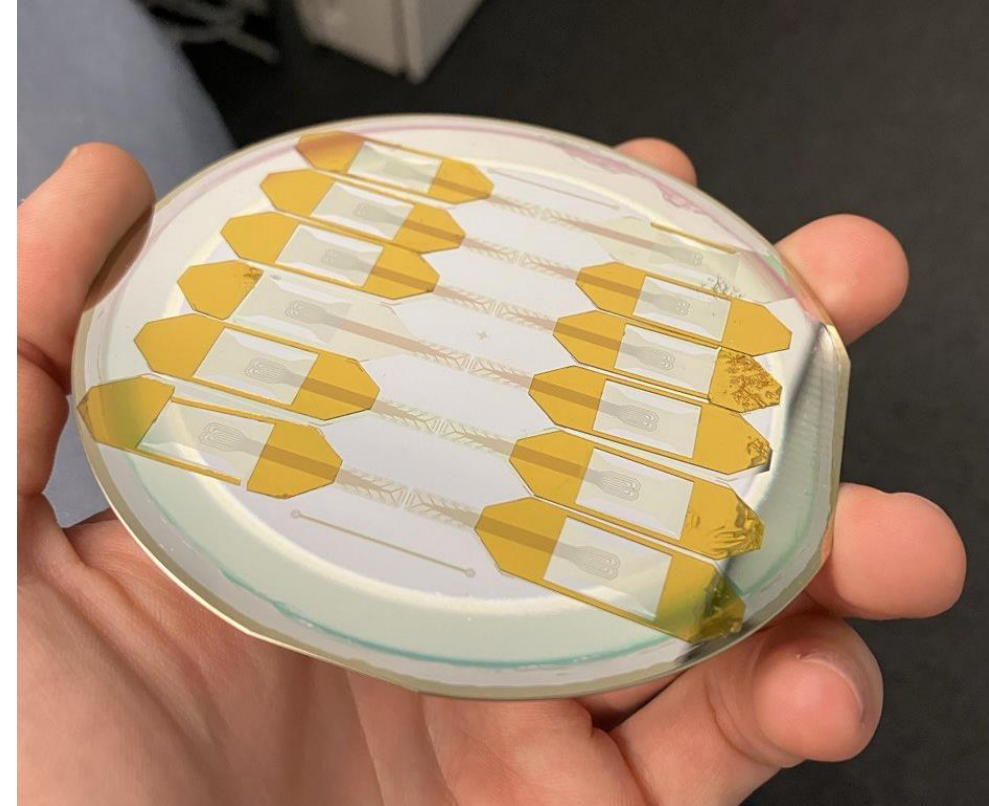
4"



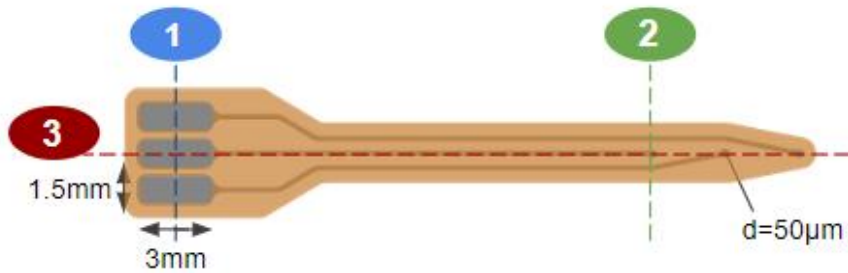
Use standard clean room fabrication processes to create neural interfaces



Thin film layers



# Basics: Flexible neural implants



A-A' **Not to scale**

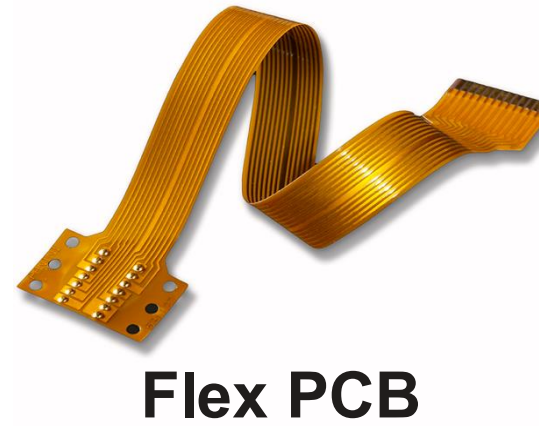
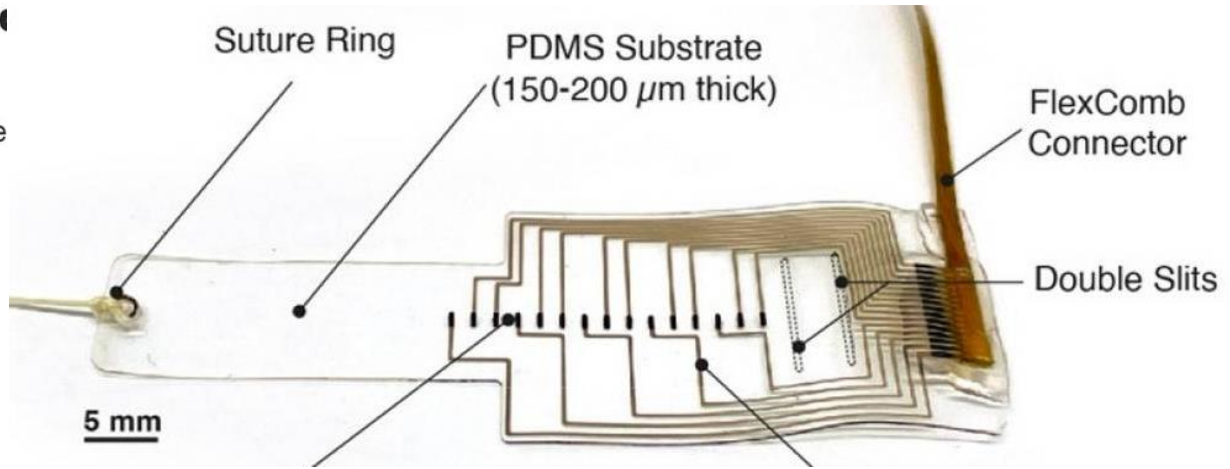
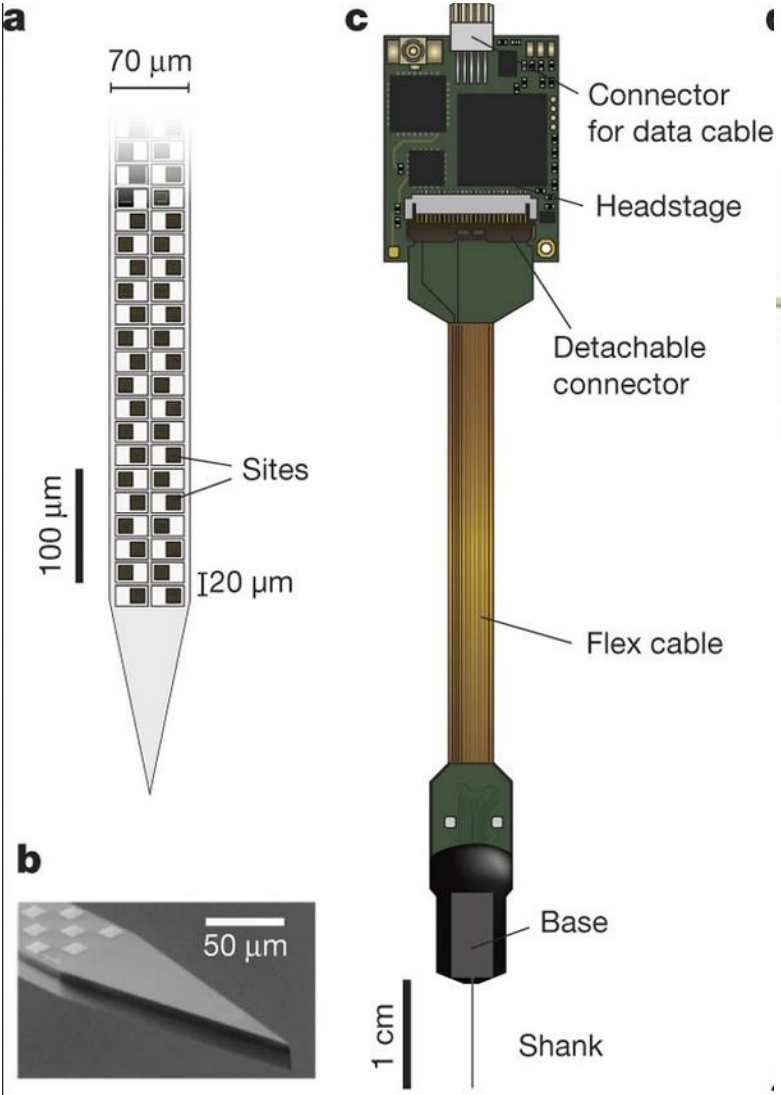
Encapsulation:  $1\mu\text{m}$  –  $1\text{mm}$  thick

Interconnect layer:  $< 1\mu\text{m}$

Substrate:  $1\mu\text{m}$  –  $1\text{mm}$  thick

- Device
- Lead
- Implant
- Paddle
- Electrodes
- Wires
- Tracks, interconnects
- Pads
- Encapsulation (top and bottom)
- Transducer layer, metalization
- Substrate
- Wafer, Carrier

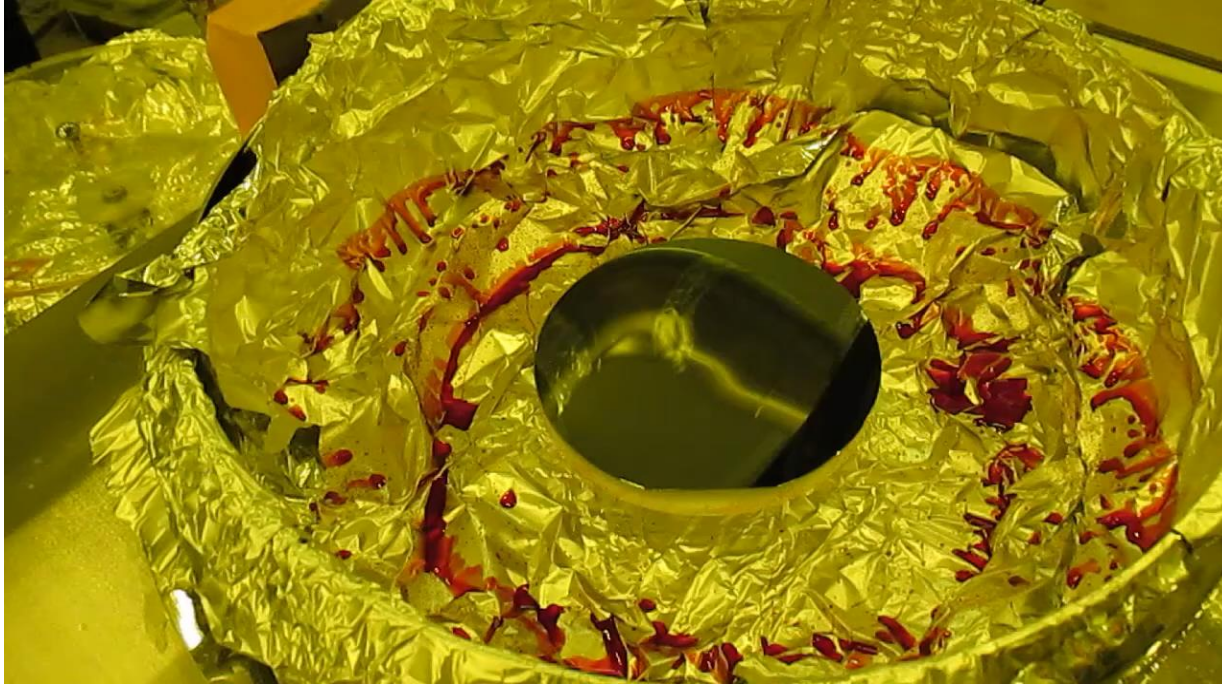
# Connecting to the neural interface



- Flex PCB, wires?
- Solder or other?
- Some epoxy?
- **Connecting to the micro-fabricated device**

# Exercise: design of a process flow

- Design a process flow for a polyimide-based device.



<https://www.youtube.com/watch?v=uSaIRYDq-Ng>

The final film thickness depends on:

- **Material concentration** in the solution
- **Solvent evaporation rate**, which is influenced by:
  - **Solvent viscosity, vapor pressure, temperature, local humidity**

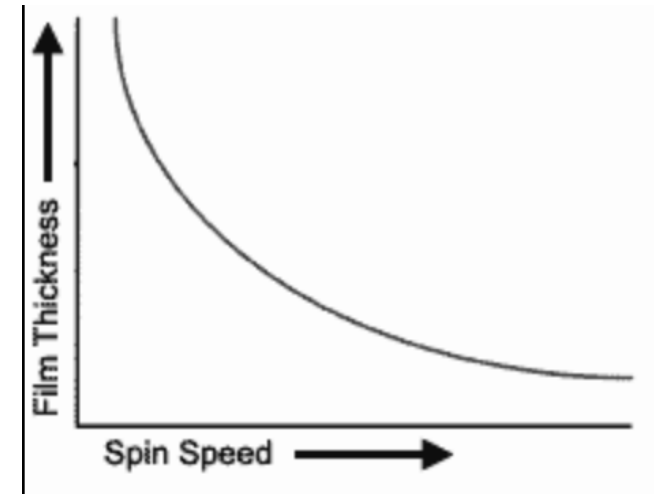
spin thickness curves are typically determined empirically.

- **Photoresists (PRs)**
- **Silicones (PDMS...)**
- **PI (Polyimide)**
- **SU-8 ...**

To consider:

- Possible inhomogeneity (uncoated areas, comets etc.)
- Different thickness along the radius

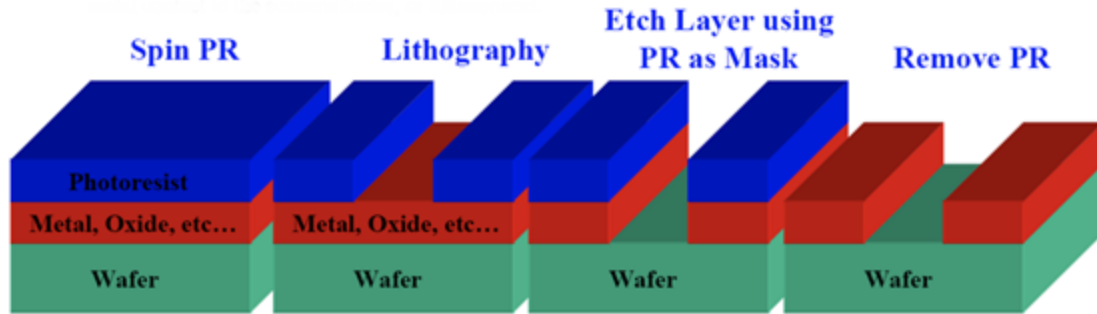
$$h_f \propto \frac{1}{\sqrt{\omega}}$$



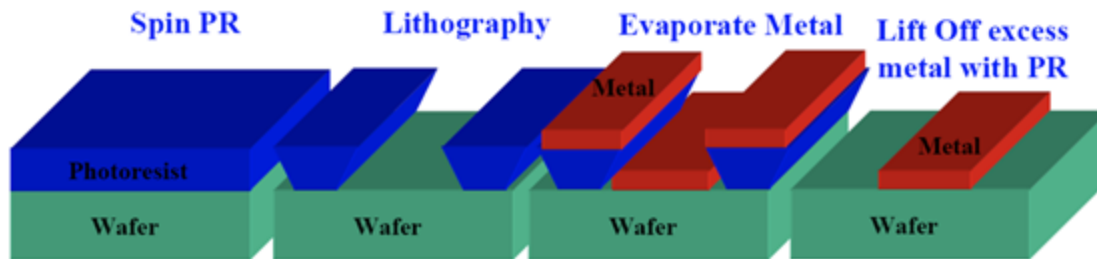
# Microfabrication: Patterning

## Etching vs Lift-Off

1.) Etching Processes:

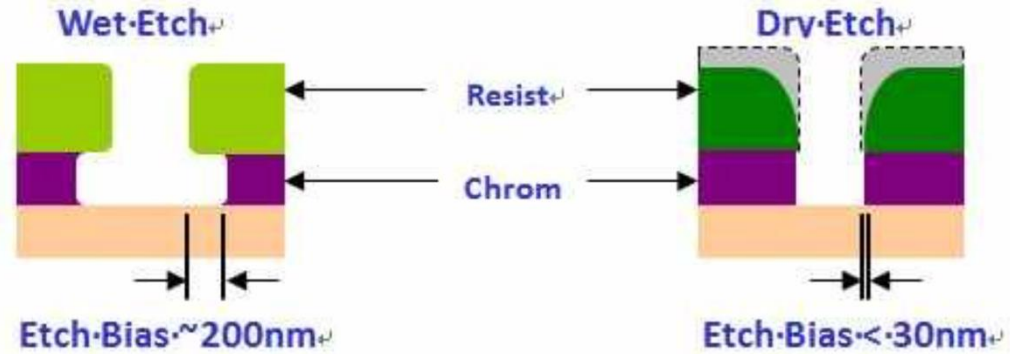


2.) Lift off Processes:



	Lift-off	Etching
Damage to substrate	Minimal	Possible, <b>etchant never perfectly selective</b>
Resolution	Limited by resist profile and mask	Limited by etchant and mask
Process complexity	<b>Resist profile</b> and deposition directionality critical	<b>Chemistry/plasma</b> must be optimized
Multi-layer structures	Easy	Different etchant per material

## Wet Etching vs Dry Etching



	Wet Etching	Dry Etching
<b>Mechanism</b>	Material is dissolved by <b>liquid chemical etchant</b>	Material is removed by <b>reactive ions or radicals in plasma</b>
<b>Anisotropy</b>	Mostly <b>isotropic</b> , etches in all directions	Highly <b>anisotropic</b>
<b>Resolution / Feature size</b>	Limited by <b>lateral etching and mask undercut</b>	Very high, suitable for fine patterns (<1 μm)
<b>Surface damage</b>	Usually gentle on surface, less physical damage	Can induce roughness, or contamination
<b>Process control</b>	Less precise, etch rate affected by diffusion and agitation	Can precisely control etch depth and rate <b>Careful sizing of PR required</b>
<b>Uniformity</b>	Very good over large areas if agitation and temperature controlled	Good over small areas, may need plasma uniformity control
<b>Material compatibility</b>	Limited to materials soluble or reactive with etchant	<b>Works for most materials</b> , including hard-to-etch metals and dielectrics
<b>Cost / equipment</b>	Simple setup, low cost, chemical baths	Requires vacuum, plasma tools → higher cost

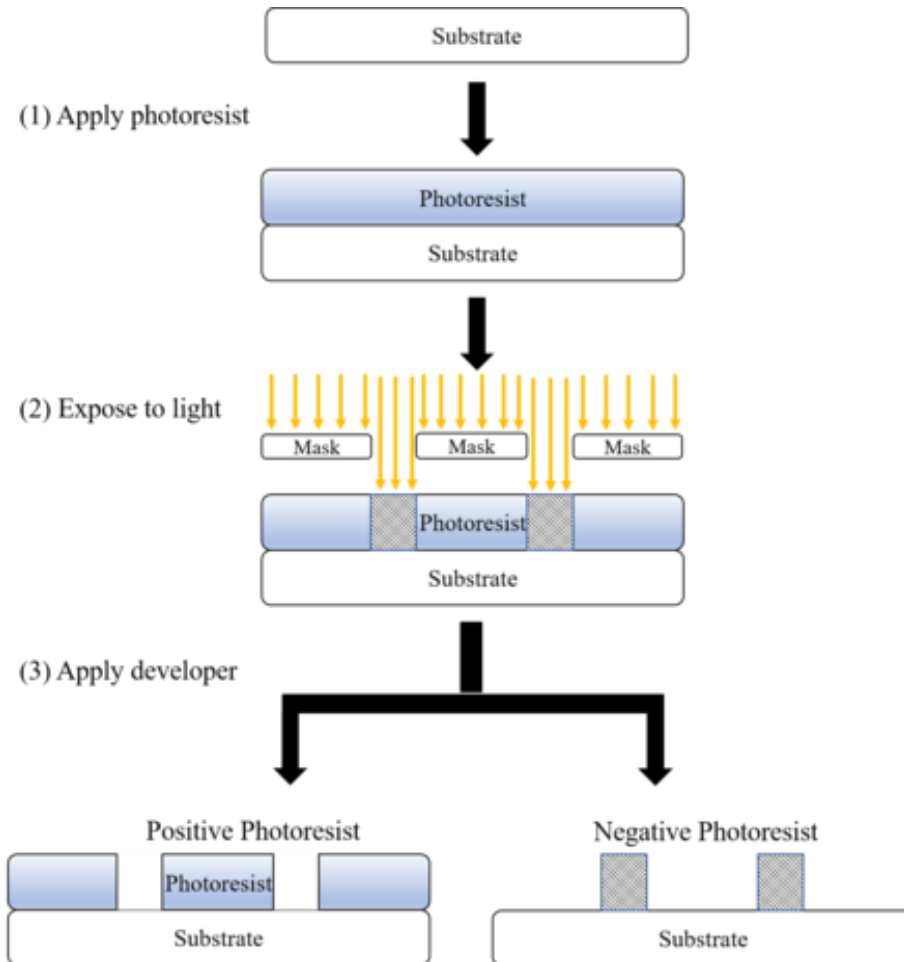
# Microfabrication: Patterning

## Example of dry etching rates

Material to etch	Chemistry	ICP power (W)	RF Power(W)	Etch rate (nm/min)	PR Etch Rate nm/min	Selectivity Material:Mask
Al	Ar/BCl <sub>3</sub>	800	50	60	590	1:10
Pt				20		1:28
Ti				110		1:5.3
TiN				110		1:5.3
Ti	Cl <sub>2</sub> /Ar	600	50	80	100	1:1.25
TiN				80	100	1:1.25
Si	SF <sub>6</sub> /Ar	800	100	58	1	1:8.5
SiO <sub>2</sub> WetOx	CHF <sub>3</sub>	800	50	233	130	1:0.6
SiO <sub>2</sub> Sputtered	Ar/CHF <sub>3</sub>	400	30	70	70	1:1
	CHF <sub>3</sub>	800	100	420	345	1:0.8
SiC	CHF <sub>3</sub> /Ar	800	100	100		
PDMS	CHF <sub>3</sub> /O <sub>2</sub>	500	150	800	450	1:0.8
Polyimide	O <sub>2</sub>	200	10	320	320	1:1
	O <sub>2</sub> /CHF <sub>3</sub>	500	150	1000	1000	1:1
	O <sub>2</sub>	500	150	1400	1400	1:1
Parylene	O <sub>2</sub>	500	150	1400	1400	1:1

# Microfabrication: Photolithography

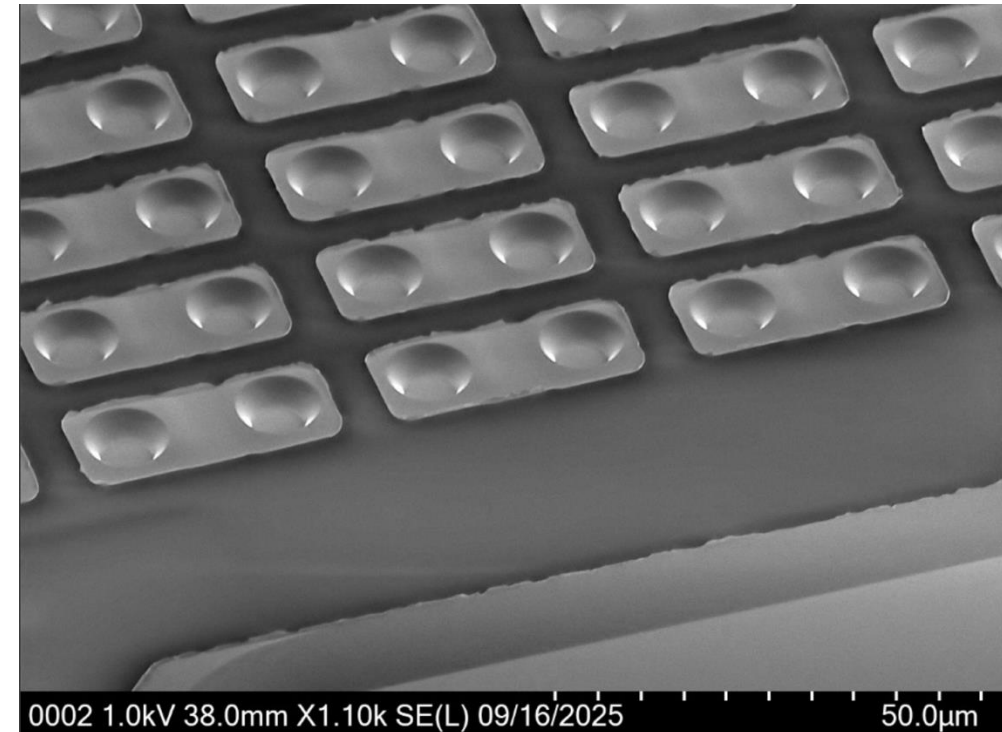
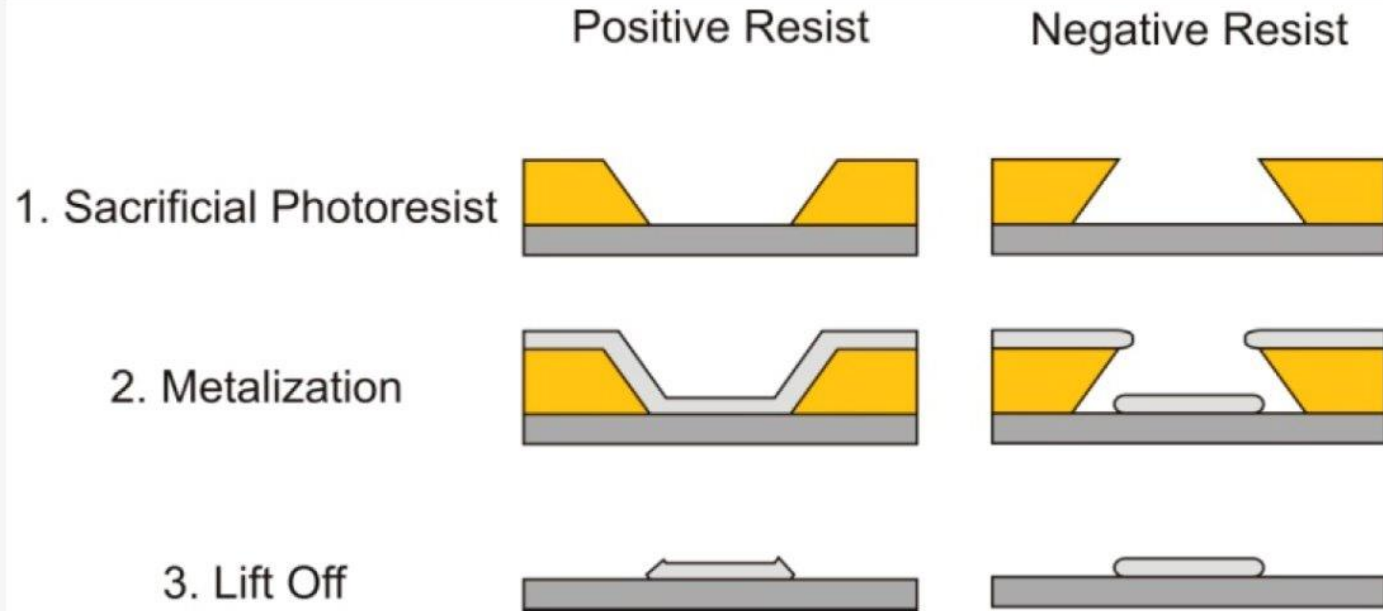
Are all the photoresist the same?  
Positive vs Negative photoresists



**Positive photoresist = the exposed goes**

*"With positive photoresist, the exposed goes;  
With negative photoresist, the exposed stays"*

When to use a positive vs negative photoresist?



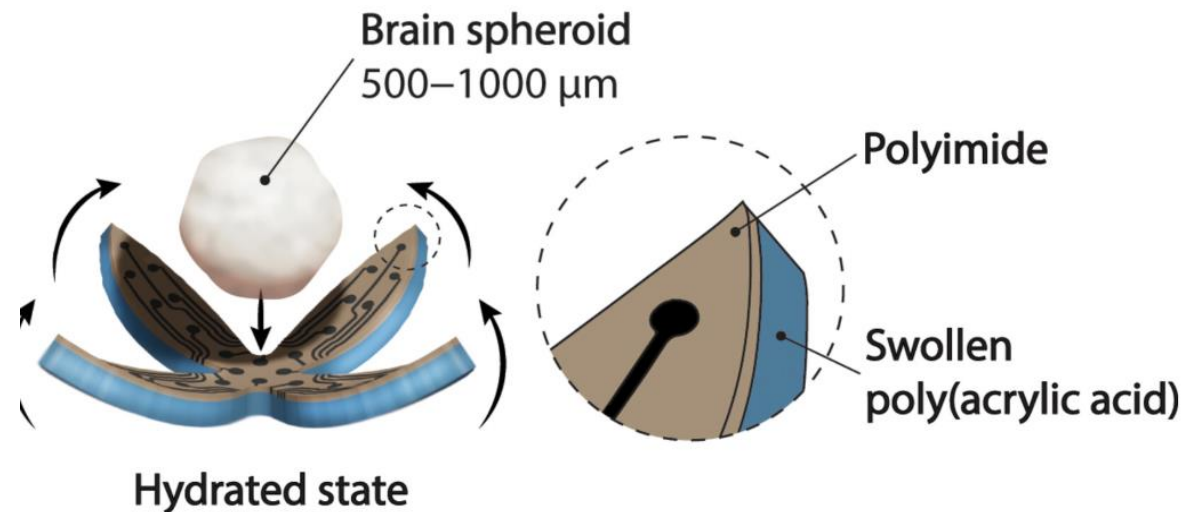
Example of Lift off with positive photoresist

# Exercise: design of a process flow

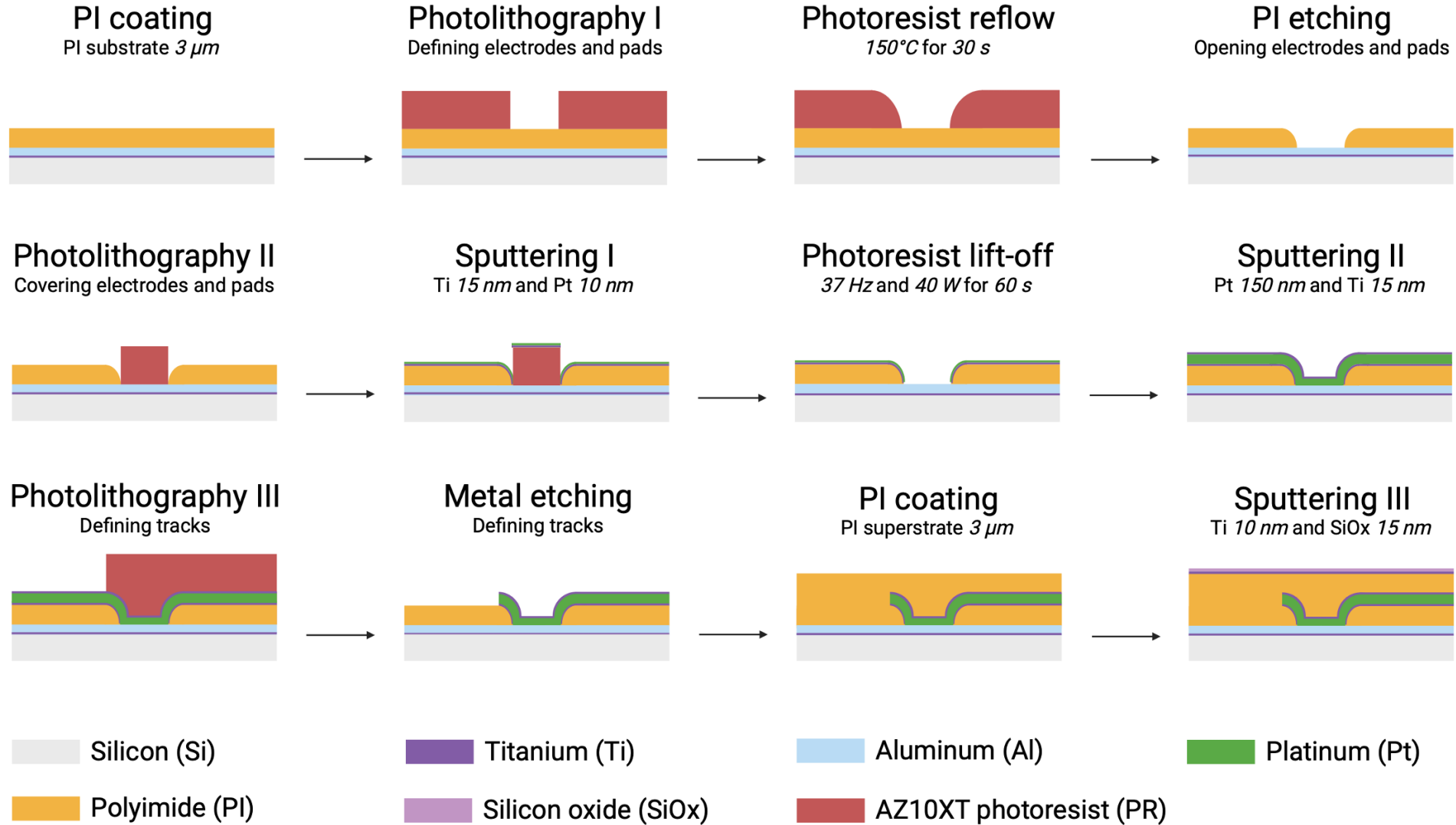
- Design a process flow for a polyimide-based device.  
Define the thicknesses of the different layers and the processes you are planning to use  
What is the total thickness of my device? Will I be able to handle it? Test/Implant it?

# Exercise: design of a process flow

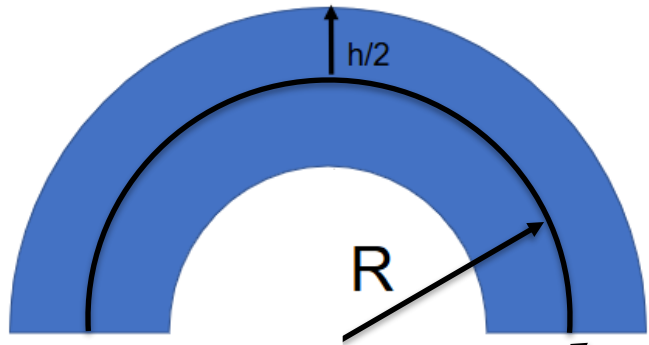
- Design a process flow for a polyimide-based device.  
Define the thicknesses of the different layers and the processes you are planning to use  
What is the total thickness of my device? Will I be able to handle it? Test/Implant it?
- Real case study: you want to graft a hydrogel to your polyimide-based device. How do you modify your process flow?



# Example of process flow



## Bending radius for single foil

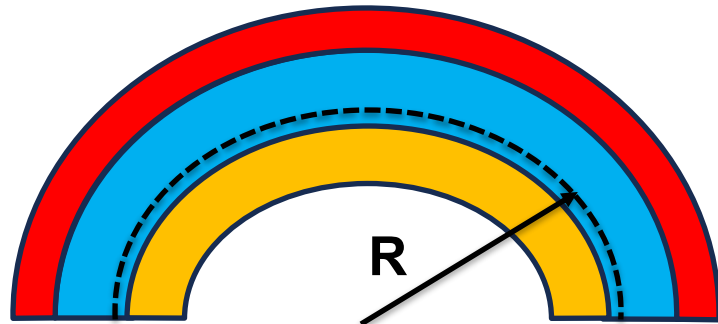


$$\varepsilon = \frac{h}{2R}$$

$\varepsilon$ : strain (%);  $h$ : film thickness;  $R$ : bending radius

Neutral plane

## Bending radius for a stack of foils

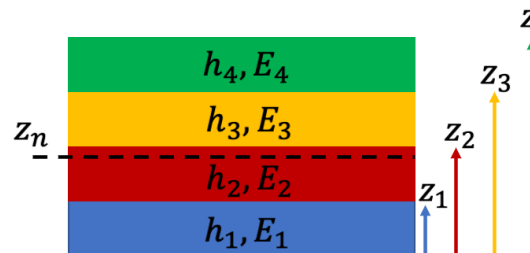


$$z_n = \frac{\sum_{i=1}^N \bar{E}_i h_i \bar{z}_i}{\sum_{i=1}^N \bar{E}_i h_i}$$

$$y_i = |z_{surface,i} - z_N|$$

$$R_{min,i} = \frac{y_i}{\varepsilon_{crit,i}}$$

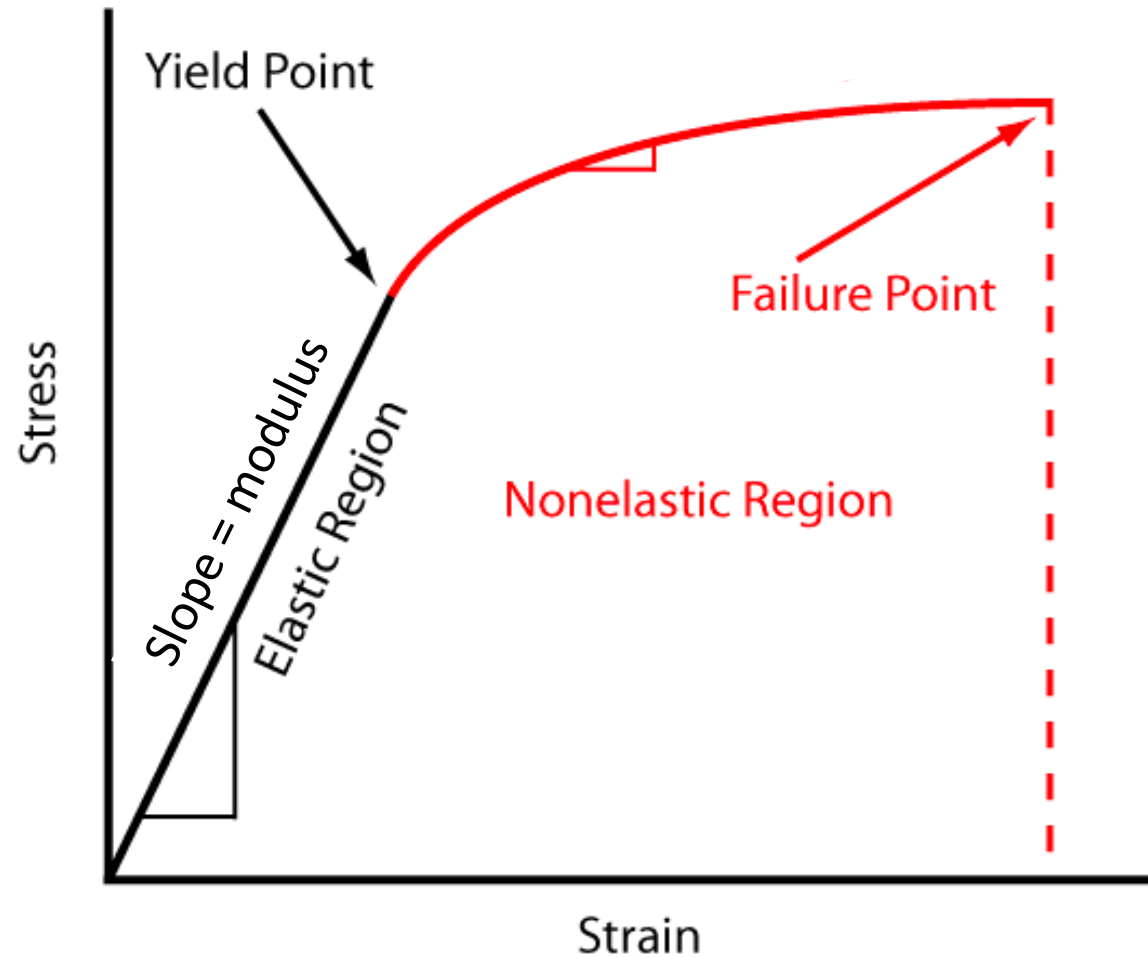
$$\varepsilon_i = \frac{y_i}{R_i}$$



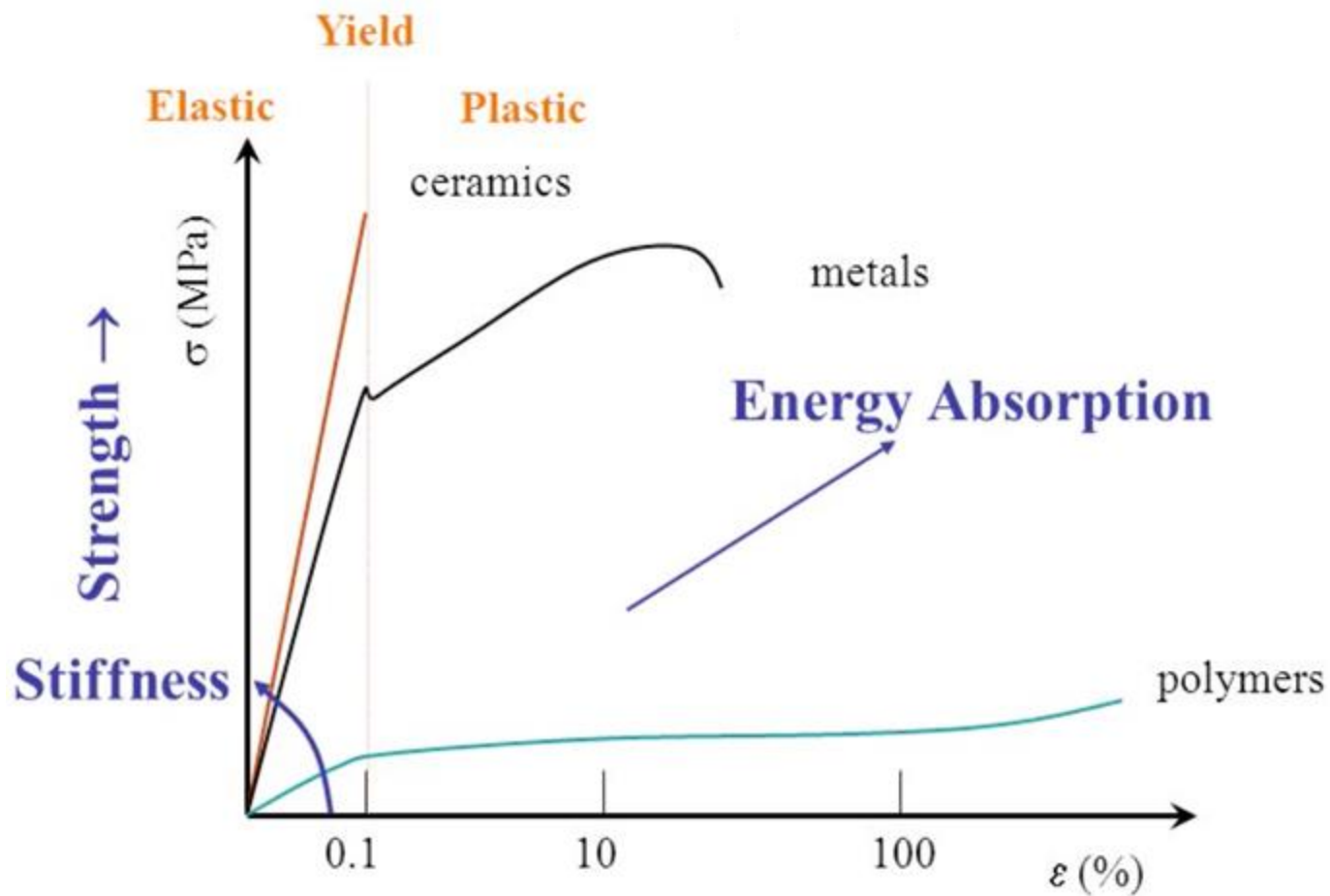
Neutral plane

$$\bar{E}_i = \frac{E_i}{(1 - \nu^2)}$$

# Tensile test on materials



# Tensile test on materials



Slope:  
Stiff  $\longleftrightarrow$  Soft

Ultimate strength:  
Strong  $\longleftrightarrow$  Weak

Plastic deformation:  
Brittle  $\longleftrightarrow$  Ductile